

N-Ch and P-Channel MOSFET

General Description

The WSP4608 is the highest performance trench N-ch and P-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

Features

- Advanced high cell density Trench technology Gate Charge
- Super Low
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Product Summery

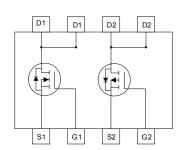
BVDSS	RDSON	ID
30V	22mΩ	6.4A
-30V	28mΩ	-5.6A

Applications

- Power management in half bridge and inverters
- DC-DC Converter
- Load Switch

SOP-8 Pin Configuration





Absolute Maximum Ratings

Symbol	Parameter	Rati		
Symbol	Farameter	N-Channel	P-Channel	Units
V _{DS}	Drain-Source Voltage	30	-30	V
V_{GS}	Gate-Source Voltage	±20	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	7	-6	Α
I _D @T _C =100℃	Continuous Drain Current, V _{GS} @ 10V ¹	6	-6	Α
I _{DM}	Pulsed Drain Current ²	30	-30	Α
EAS	Single Pulse Avalanche Energy ³	72	59	mJ
I _{AS}	Avalanche Current	21	-19	Α
P _D @T _C =25℃	Total Power Dissipation ⁴	1	1	W
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	$^{\circ}$
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	$^{\circ}\!$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-Ambient ¹		83	°C/W
R _{eJC}	Thermal Resistance Junction-Case ¹		51	°C/W





Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30	33		V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.035		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =6.4A		22		0
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =5.2A		34		mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} . In =250uA		1.5		V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D -250uA		-5.8		mV/℃
	Drain Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	— uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55℃			5	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20 V$, $V_{DS}=0 V$			±100	nA
gfs	Forward Transconductance	V _{DS} =15V , I _D =5A		7.3		S
R_g	Gate Resistance	V _{DS} =20V , V _{GS} =0V , f=1MHz		2.4		Ω
Qg	Total Gate Charge (4.5V)			7.2		
Q _{gs}	Gate-Source Charge	V _{DS} =20V , V _{GS} =4.5V , I _D =6A		1.4		nC
Q _{gd}	Gate-Drain Charge			2.2		
T _{d(on)}	Turn-On Delay Time			4.1		
Tr	Rise Time	V_{DD} =15V , V_{GS} =10V , R_{G} =3 Ω		9.8		
T _{d(off)}	Turn-Off Delay Time	I _D =5A		15.5		ns
T _f	Fall Time			6.0		
C _{iss}	Input Capacitance	V _{DS} =25V , V _{GS} =0V , f=1MHz		407		
C _{oss}	Output Capacitance			113		pF
C _{rss}	Reverse Transfer Capacitance			57		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =10A	16			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			6	Α
I _{SM}	Pulsed Source Current ^{2,6}				23	Α
V_{SD}	Diode Forward Voltage ²	V_{GS} =0 V , I_{S} =5 A , T_{J} =25 $^{\circ}$ \mathbb{C}			1.1	V

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =10A
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30	-34		V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25℃ , I _D =-1mA		-0.085		V/°C
В	Chatia Basia Carras On Basiatana 2	V _{GS} =-10V , I _D =-5.6A		28		mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-5.05A		36		1117.5
V _{GS(th)}	Gate Threshold Voltage	V -V I - 250::A		-1.5		V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	$V_{GS}=V_{DS}$, $I_D=-250uA$		0.375		mV/℃
	Drain Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25℃			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55℃			5	– uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 24V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-6A		12		S
Qg	Total Gate Charge (-4.5V)			6.4		
Q_gs	Gate-Source Charge	V _{DS} =-20V , V _{GS} =-4.5V , I _D =-6A		2.7		nC
Q _{gd}	Gate-Drain Charge			3.1		
T _{d(on)}	Turn-On Delay Time			8		
T _r	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_{G} =3 Ω ,		16.6		
T _{d(off)}	Turn-Off Delay Time	R_L =2.5 Ω		22		ns
T _f	Fall Time			21.6		
C _{iss}	Input Capacitance			950		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		137		pF
C _{rss}	Reverse Transfer Capacitance			118		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-25V , L=0.1mH , I _{AS} =-10A	16			mJ

Diode Characteristics

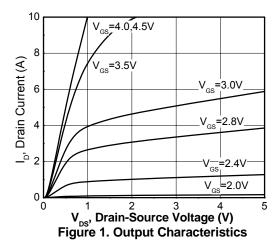
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			-6	Α
I _{SM}	Pulsed Source Current ^{2,6}				-12	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-6A , T _J =25℃			-1.2	V

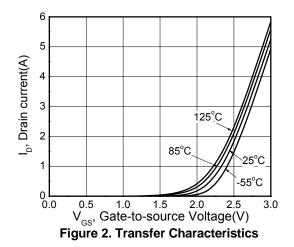
Note:

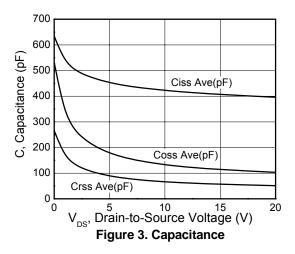
- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-10A
- 4.The power dissipation is limited by 150 ℃ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

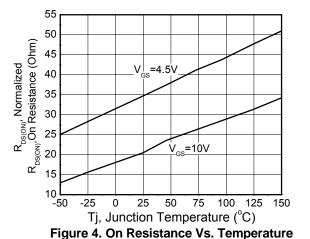


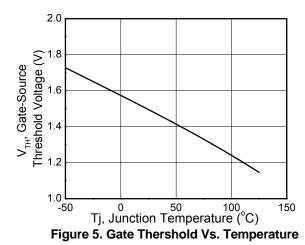
N-Channel Typical Characteristics

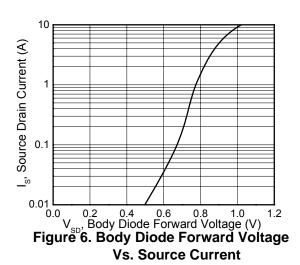






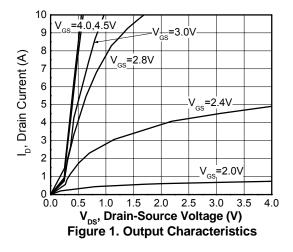








P-Channel Typical Characteristics



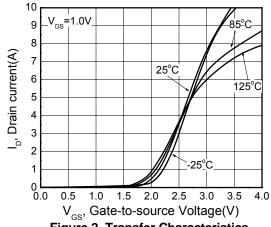
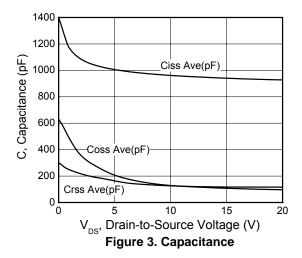


Figure 2. Transfer Characteristics



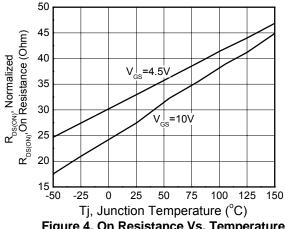


Figure 4. On Resistance Vs. Temperature

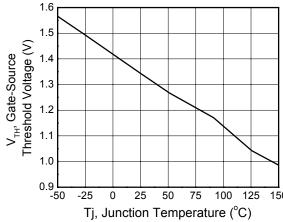
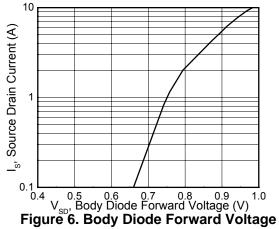


Figure 5. Gate Thershold Vs. Temperature



Vs. Source Current



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